VN920PEP

SINGLE CHANNEL HIGH SIDE SOLID STATE RELAY

TARGET SPECIFICATION

TYPE	$R_{DS(on)}$	I_{OUT}	V_{CC}
VN920PEP	15mΩ	30 A	36 V

- CMOS COMPATIBLE INPUT
- PROPORTIONAL LOAD CURRENT SENSE
- SHORTED LOAD PROTECTION
- UNDERVOLTAGE AND OVERVOLTAGE SHUTDOWN
- OVERVOLTAGE CLAMP
- THERMAL SHUTDOWN
- CURRENT LIMITATION
- PROTECTION AGAINST LOSS OF GROUND AND LOSS V_{CC}
- VERY LOW STAND-BY POWER DISSIPATION
- REVERSE BATTERY PROTECTION (*)

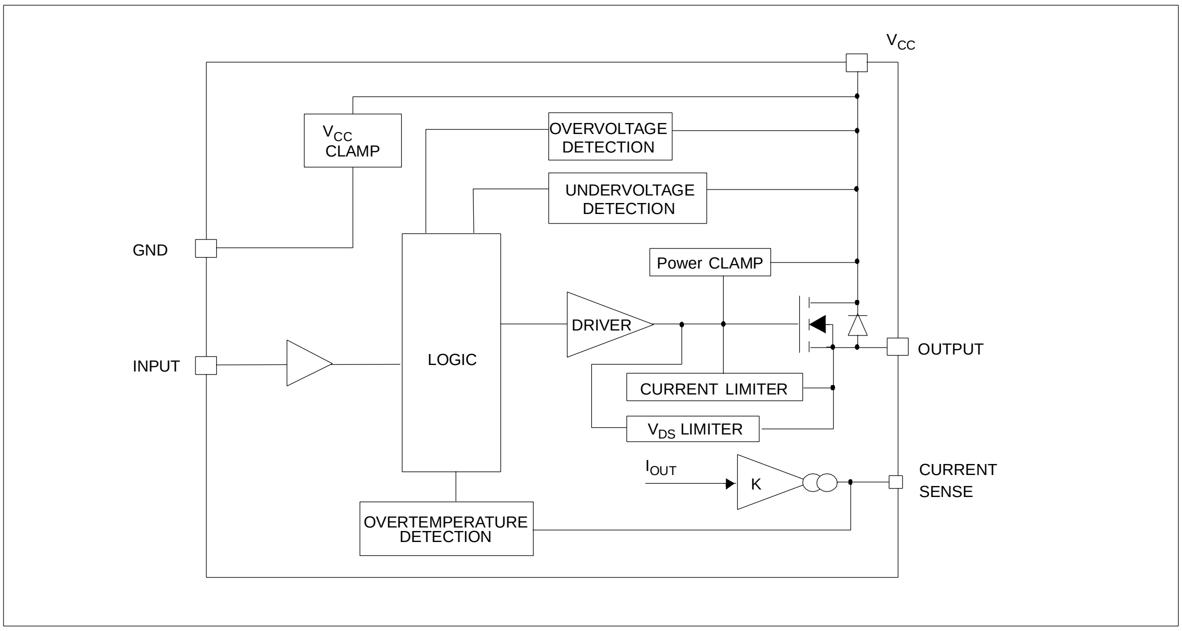
PowerSSO-24

ORDER CODES		
PACKAGE	TUBE	T&R
PowerSSO-24	VN920PEP	VN920PEP13TR

DESCRIPTION

The VN920PEP is a monolithic device designed in STMicroelectronics VIPower M0-3 Technology, intended for driving any kind of load with one side connected to ground. Active V_{CC} pin voltage clamp protects the device against low energy spikes (see ISO7637 transient compatibility table). Active current limitation combined with thermal shutdown and automatic restart protect the device against overload. The device integrates an analog current sense output which delivers a current proportional to the load current. Device automatically turns off in case of ground pin disconnection.

BLOCK DIAGRAM



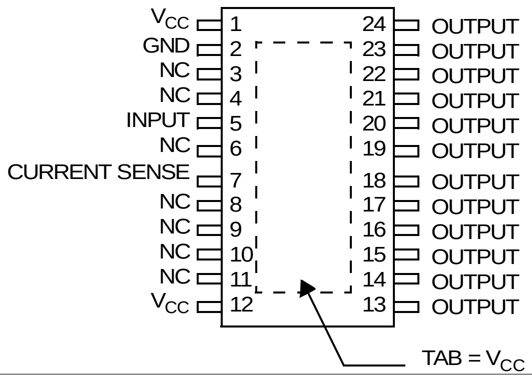
(*) See application schematic at page 8

This is preliminary information on a new product foreseen to be developed. Details are subject to change without notice.

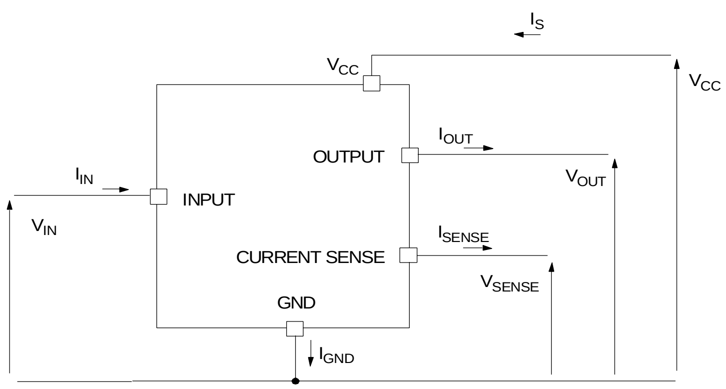
ABSOLUTE MAXIMUM RATING

Symbol	Parameter	Value	Unit
V_{CC}	DC Supply Voltage	41	V
$- V_{CC}$	Reverse DC Supply Voltage	- 0.3	V
$- I_{GND}$	DC Reverse Ground Pin Current	- 200	mA
I_{OUT}	DC Output Current	Internally Limited	A
$- I_{OUT}$	Reverse DC Output Current	- 40	A
I_{IN}	DC Input Current	+/- 10	mA
V_{CSENSE}	Current Sense Maximum Voltage	-3 +15	V V
V_{ESD}	Electrostatic Discharge (Human Body Model: R=1.5KΩ; C=100pF) - INPUT - CURRENT SENSE - OUTPUT - V_{CC}	 4000 2000 5000 5000	 V V V V
P_{tot}	Power Dissipation T_C≤25°C	96	W
T_j	Junction Operating Temperature	Internally limited	°C
T_c	Case Operating Temperature	- 40 to 150	°C
T_{STG}	Storage Temperature	- 55 to 150	°C

CONNECTION DIAGRAM (TOP VIEW)



CURRENT AND VOLTAGE CONVENTIONS



THERMAL DATA

Symbol	Parameter		Value	Unit
$R_{thj\text{-}case}$	Thermal Resistance Junction-case	Max	1.3	°C/W
$R_{thj\text{-}amb}$	Thermal Resistance Junction-ambient	Max	60 (*)	°C/W

(*) When mounted on a standard single-sided FR-4 board with 1cm^2 of Cu (at least 35µm thick).

ELECTRICAL CHARACTERISTICS (8V<V_{CC}<36V; -40°C<T_j<150°C unless otherwise specified)

POWER

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V_{CC}	Operating Supply Voltage		5.5	13	36	V
V_{USD}	Undervoltage Shut-down		3	4	5.5	V
V_{OV}	Overvoltage Shut-down		36			V
R_{ON}	On State Resistance	I_{OUT}=10A; T_j =25°C I_{OUT}=10A I_{OUT}=3A; V_{CC}=6V			15 30 50	mΩ mΩ mΩ
V_{clamp}	Clamp Voltage	I_{CC}=20mA (See note 1)	41	48	55	V
I_S	Supply Current	Off State; V_{CC}=13V; V_{IN}=V_{OUT}=0V Off State; V_{CC}=13V; T_j=25°C; V_{IN}=V_{OUT}=0V On State; V_{CC}=13V; V_{IN}=5V; I_{OUT}=0; R_{SENSE}=3.9KΩ		10 10	25 20 5	µA µA mA
$I_{L(off1)}$	Off State Output Current	V_{IN}=V_{OUT}=V_{SENSE}=0V	0		50	µA
$I_{L(off2)}$	Off State Output Current	V_{IN}=V_{SENSE}=0V; V_{OUT}=3.5V	-75		0	µA
$I_{L(off3)}$	Off State Output Current	V_{IN}=V_{OUT}=V_{SENSE}=0V; V_{CC}=13V;T_j=125°C			5	µA
$I_{L(off4)}$	Off State Output Current	V_{IN}=V_{OUT}=V_{SENSE}=0V; V_{CC}=13V; T_j =25°C			3	µA

SWITCHING (V_{CC}=13V)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
$t_{d(on)}$	Turn-on Delay Time	R_L=1.3Ω (see figure 2)		50		µs
$t_{d(off)}$	Turn-off Delay Time	R_L=1.3Ω (see figure 2)		50		µs
$dV_{OUT}/dt_{(on)}$	Turn-on Voltage Slope	R_L=1.3Ω (see figure 2)		See relative diagram		V/µs
$dV_{OUT}/dt_{(off)}$	Turn-off Voltage Slope	R_L=1.3Ω (see figure 2)		See relative diagram		V/µs

LOGIC INPUT

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V_{IL}	Input Low Level				1.25	V
I_{IL}	Low Level Input Current	V_{IN}=1.25V	1			µA
V_{IH}	Input High Level		3.25			V
I_{IH}	High Level Input Current	V_{IN}=3.25V			10	µA
$V_{I(hyst)}$	Input Hysteresis Voltage		0.5			V
V_{ICL}	Input Clamp Voltage	I_{IN}=1mA I_{IN}=-1mA	6	6.8 -0.7	8	V V

Note 1: V_{clamp} and V_{OV} are correlated. Typical difference is 5V.

ELECTRICAL CHARACTERISTICS (continued)

CURRENT SENSE ($9V \leq V_{CC} \leq 16V$) (See Fig. 1)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
K_1	I_{OUT}/I_{SENSE}	I_{OUT}=1A; V_{SENSE}=0.5V; T_j= -40°C...150°C	3300	4400	6000	
dK_1/K_1	Current Sense Ratio Drift	I_{OUT}=1A; V_{SENSE}=0.5V; T_j= -40°C...+150°C	-10		+10	%
K_2	I_{OUT}/I_{SENSE}	I_{OUT}=10A; V_{SENSE}=4V; T_j=-40°C T_j=25°C...150°C	4200 4400	4900 4900	6000 5750	
dK_2/K_2	Current Sense Ratio Drift	I_{OUT}=10A; V_{SENSE}=4V; T_j=-40°C...+150°C	-8		+8	%
K_3	I_{OUT}/I_{SENSE}	I_{OUT}=30A; V_{SENSE}=4V; T_j=-40°C T_j=25°C...150°C	4200 4400	4900 4900	5500 5250	
dK_3/K_3	Current Sense Ratio Drift	I_{OUT}=30A; V_{SENSE}=4V; T_j=-40°C...+150°C	-6		+6	%
I_{SENSEO}	Analog Sense Leakage Current	V_{CC}=6...16V; I_{OUT}=0A;V_{SENSE}=0V; T_j=-40°C...+150°C	0		10	µA
V_{SENSE}	Max Analog Sense Output Voltage	V_{CC}=5.5V; I_{OUT}=5A; R_{SENSE}=10KΩ V_{CC}>8V; I_{OUT}=10A; R_{SENSE}=10KΩ	2 4			V V
V_{SENSEH}	Sense Voltage in Overtemperature conditions	V_{CC}=13V; R_{SENSE}=3.9KΩ		5.5		V
$R_{VSENSEH}$	Analog sense output impedance in overtemperature condition	V_{CC}=13V; Tj>T_{TSD}; Output Open		400		Ω
t_{DSENSE}	Current sense delay response	to 90% I_{SENSE} (see note 2)			500	µs

PROTECTIONS

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
T_{TSD}	Shut-down Temperature		150	175	200	°C
T_R	Reset Temperature		135			°C
T_{hyst}	Thermal Hysteresis		7	15		°C
I_{lim}	DC Short Circuit Current	V_{CC}=13V 5V<V_{CC}<36V	30	45	75 75	A A
V_{demag}	Turn-off Output Clamp Voltage	I_{OUT}=2A; V_{IN}=0V; L=6mH	V_{CC}-41	V_{CC}-48	V_{CC}-55	V
V_{ON}	Output Voltage Drop Limitation	I_{OUT}=1A; T_j=-40°C....+150°C		50		mV

VCC - OUTPUT DIODE

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V_F	Forward on Voltage	-I_{OUT}=5.5A; T_j=150°C			0.7	V

Note 2: current sense signal delay after positive input slope
Note: Sense pin doesn’t have to be left floating.

Figure 1: I_{OUT}/I_{SENSE} versus I_{OUT}

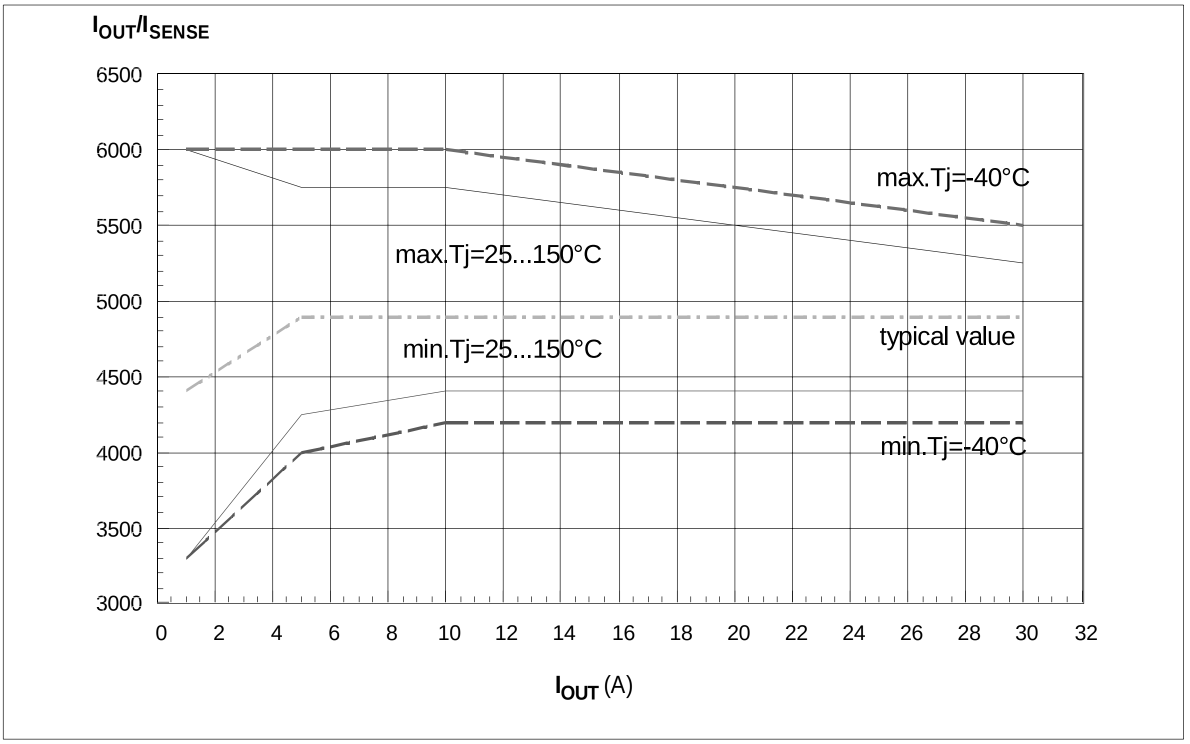
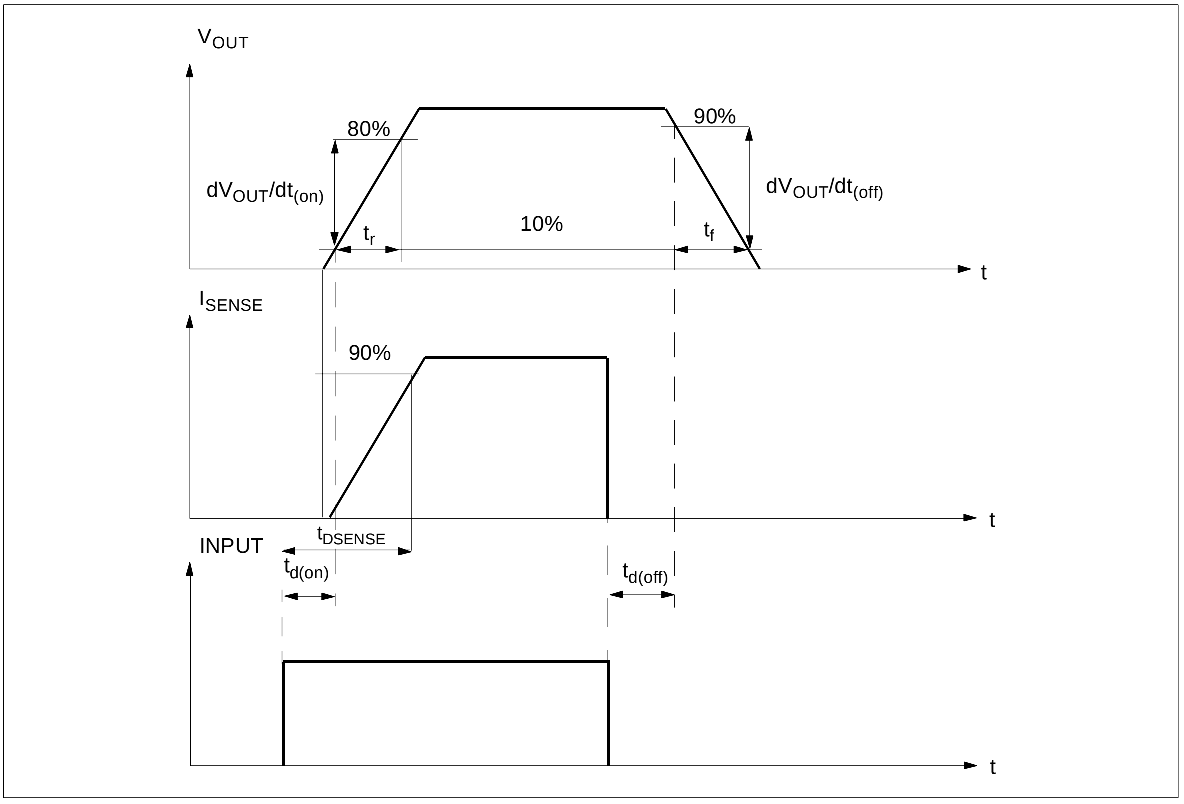


Figure 2: Switching Characteristics (Resistive load R_L=1.3Ω)



TRUTH TABLE

CONDITIONS	INPUT	OUTPUT	SENSE
Normal operation	L H	L H	0 Nominal
Overtemperature	L H	L L	0 V_{SENSEH}
Undervoltage	L H	L L	0 0
Overvoltage	L H	L L	0 0
Short circuit to GND	L H H	L L L	0 ($T_j<T_{TSD}$) 0 ($T_j>T_{TSD}$) V_{SENSEH}
Short circuit to V_{CC}	L H	H H	0 < Nominal
Negative output voltage clamp	L	L	0

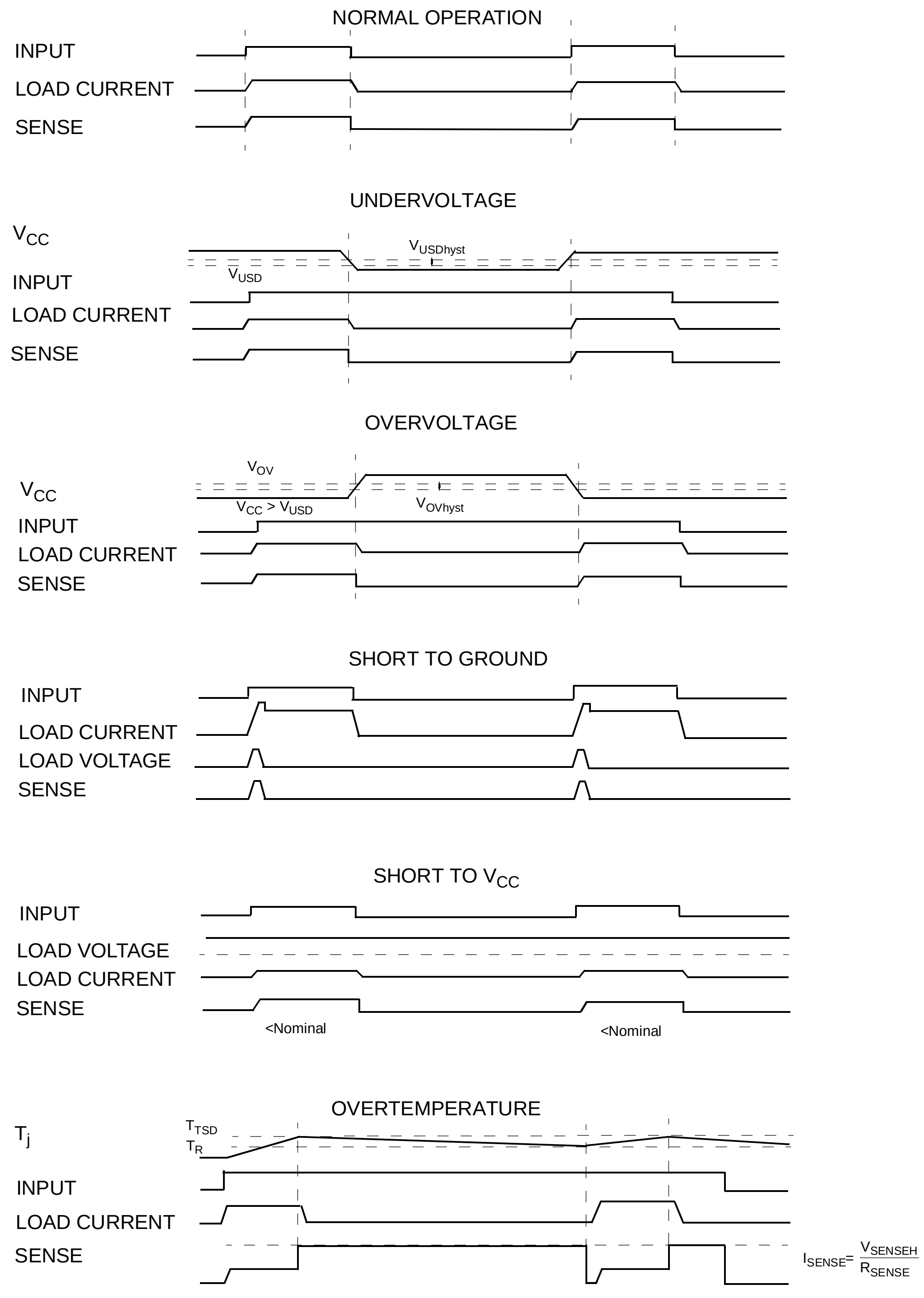
ELECTRICAL TRANSIENT REQUIREMENTS

ISO T/R 7637/1 Test Pulse	TEST LEVELS				
	I	II	III	IV	Delays and Impedance
1	-25 V	-50 V	-75 V	-100 V	2 ms 10 Ω
2	+25 V	+50 V	+75 V	+100 V	0.2 ms 10 Ω
3a	-25 V	-50 V	-100 V	-150 V	0.1 µs 50 Ω
3b	+25 V	+50 V	+75 V	+100 V	0.1 µs 50 Ω
4	-4 V	-5 V	-6 V	-7 V	100 ms, 0.01 Ω
5	+26.5 V	+46.5 V	+66.5 V	+86.5 V	400 ms, 2 Ω

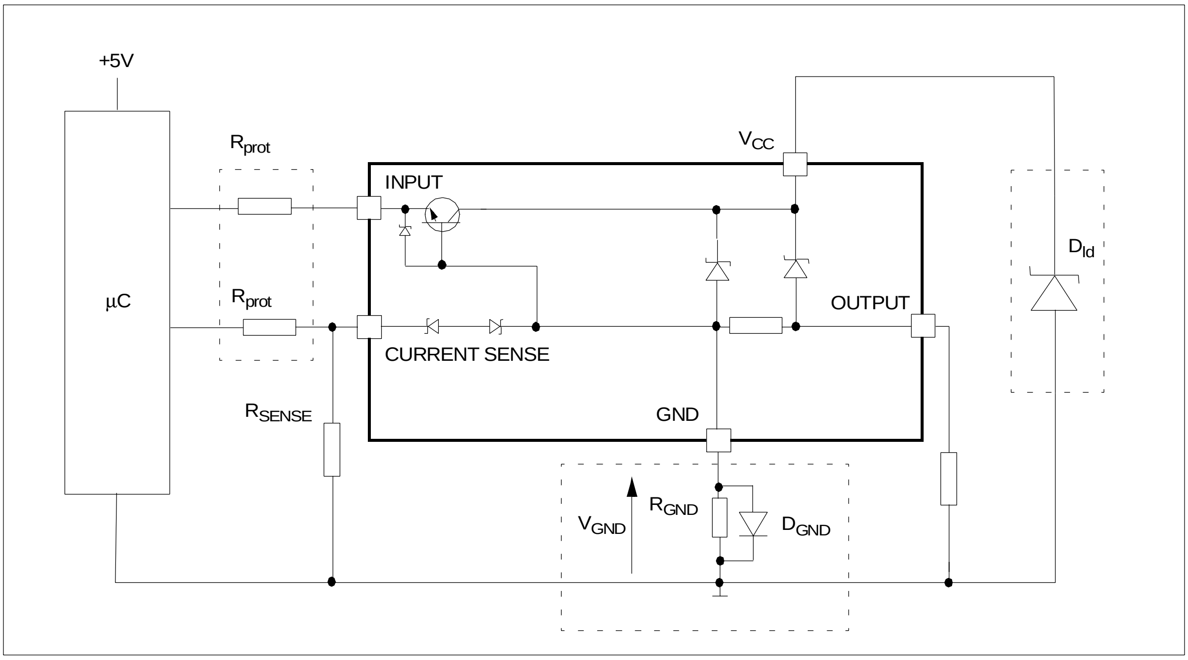
ISO T/R 7637/1 Test Pulse	TEST LEVELS RESULTS			
	I	II	III	IV
1	C	C	C	C
2	C	C	C	C
3a	C	C	C	C
3b	C	C	C	C
4	C	C	C	C
5	C	E	E	E

CLASS	CONTENTS
C	All functions of the device are performed as designed after exposure to disturbance.
E	One or more functions of the device is not performed as designed after exposure to disturbance and cannot be returned to proper operation without replacing the device.

Figure 3: Waveforms



APPLICATION SCHEMATIC



GND PROTECTION NETWORK AGAINST REVERSE BATTERY

Solution 1: Resistor in the ground line (R_{GND} only). This can be used with any type of load.

The following is an indication on how to dimension the R_{GND} resistor.

1) $R_{GND} \leq 600mV / (I_{S(on)max})$.

2) $R_{GND} \geq (-V_{CC}) / (-I_{GND})$

where $-I_{GND}$ is the DC reverse ground pin current and can be found in the absolute maximum rating section of the device's datasheet.

Power Dissipation in R_{GND} (when V_{CC}<0: during reverse battery situations) is:

$P_D = (-V_{CC})^2/R_{GND}$

This resistor can be shared amongst several different HSD. Please note that the value of this resistor should be calculated with formula (1) where $I_{S(on)max}$ becomes the sum of the maximum on-state currents of the different devices.

Please note that if the microprocessor ground is not common with the device ground then the R_{GND} will produce a shift ($I_{S(on)max} * R_{GND}$) in the input thresholds and the status output values. This shift will vary depending on how many devices are ON in the case of several high side drivers sharing the same R_{GND}.

If the calculated power dissipation leads to a large resistor or several devices have to share the same resistor then the ST suggests to utilize Solution 2 (see below).

Solution 2: A diode (D_{GND}) in the ground line.

A resistor (R_{GND}=1kΩ) should be inserted in parallel to D_{GND} if the device will be driving an inductive load.

This small signal diode can be safely shared amongst several different HSD. Also in this case, the presence of the ground network will produce a shift (≃600mV) in the input threshold and the status output values if the microprocessor ground is not common with the device ground. This shift will not vary if more than one HSD shares the same diode/resistor network.

Series resistor in INPUT line is also required to prevent that, during battery voltage transient, the current exceeds the Absolute Maximum Rating.

Safest configuration for unused INPUT pin is to leave it unconnected, while unused SENSE pin has to be connected to Ground pin.

LOAD DUMP PROTECTION

D_{ld} is necessary (Voltage Transient Suppressor) if the load dump peak voltage exceeds V_{CC} max DC rating. The same applies if the device will be subject to transients on the V_{CC} line that are greater than the ones shown in the ISO T/R 7637/1 table.

μC I/Os PROTECTION:

If a ground protection network is used and negative transients are present on the V_{CC} line, the control pins will be pulled negative. ST suggests to insert a resistor (R_{prot}) in line to prevent the μC I/Os pins to latch-up.

The value of these resistors is a compromise between the leakage current of μC and the current required by the HSD I/Os (Input levels compatibility) with the latch-up limit of μC I/Os.

$-V_{CCpeak}/I_{latchup} \leq R_{prot} \leq (V_{OH\mu C}-V_{IH}-V_{GND}) / I_{IHmax}$

Calculation example:

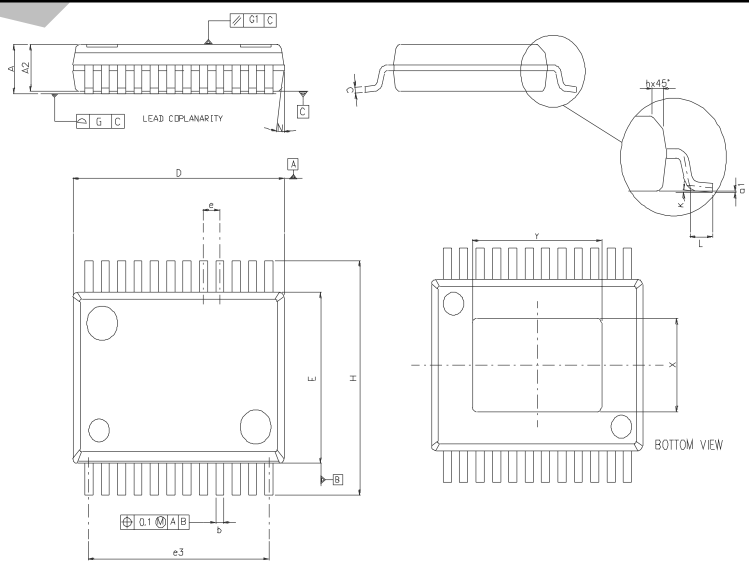
For V_{CCpeak}= - 100V and $I_{latchup} \geq$ 20mA; $V_{OH\mu C} \geq$ 4.5V

5kΩ ≤ R_{prot} ≤ 65kΩ.

Recommended R_{prot} value is 10kΩ.

PowerSSO-24™ MECHANICAL DATA

DIM.	mm.		
	MIN.	TYP	MAX.
A	1.9		2.22
A2	1.9		2.15
a1	0		0.07
b	0.34	0.4	0.46
c	0.23		0.32
D	10.2		10.4
E	7.4		7.6
e		0.8	
e3		8.8	
G			0.1
G1			0.06
H	10.1		10.5
h			0.4
L	0.55		0.85
N			10º
X	3.9		4.3
Y	6.1		6.5



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